

Test item list

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Num	Item	Spec
1.	Low Noise Medical Station:	Onyx-215
	1.LCD	LCD.15".CPT.CLAA150XP03.Ver1.0-040206.4LAMP
	2.Power Adapter	EDAC EA1050A-120
	3. Inverter	INVERTER Cable.6P 2.00mm.5P 2.00mm.30cm
	4. A/D Board	BT-R08LDNQ REV:05
	5. USB Transfer Board	T040 REV:A02
	6. USB Board	1907YC0301 REV:A1.0
	7. CD-ROM Transfer Board	1907T04101 REV:A0.2
	8. Smart card Board	MR0103
	9. Card Reader Board	GS-2004-CR18801 V1.1
	10. CD-ROM	TEAC DW-224E
2.	Test System	AEC-6900 (PCM-6892 B1.0 / 256MB / BIOS:0.2)



Temperature cycle test

Test Date: 01-13~16-2006

Test Product: Onyx-215

Test Site: AAEON QA Internal Lab.

Performed By: Ryan Cheng

Test Standard: Reference IEC68-2-14 Testing procedures
Test N: Change of temperature Test

Test Equipment:

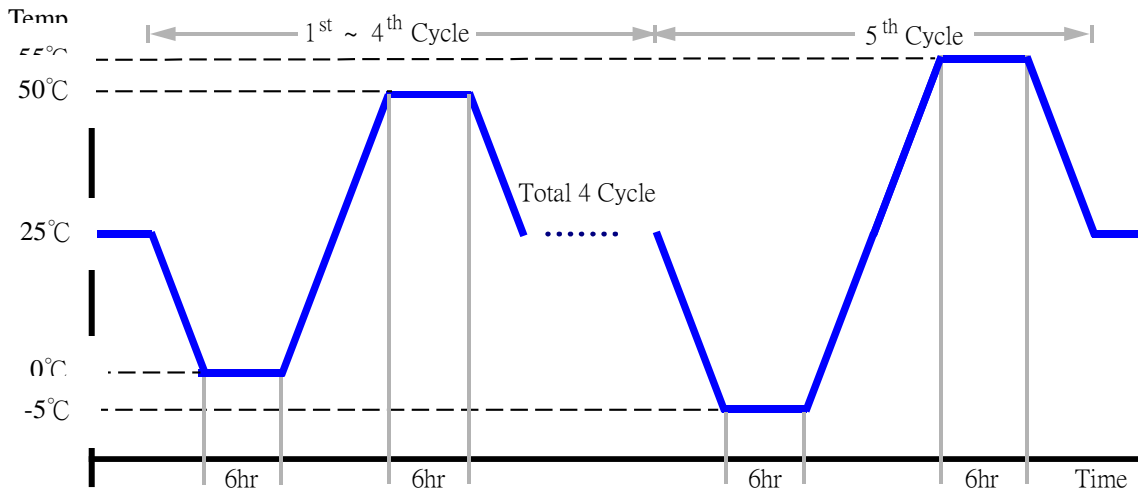
Programmable Temperature & Humidity Chamber
K.SON. INS. TECH. CORP.
Model: THS-D4L+-100
Date of Calibration: 11/21/05
Serial Number: 2582

Temperature Measurement:

20 Channel Thermal Recorder:
YOKOGAWA Inc,
Model: DA100-13-1D
Date of Calibration: 12/25/04
Serial Number: 12A323190

Test Condition:

1. Test Low Temperature: 0°C (1~4 cycle)
-5°C (5th cycle)
2. Test High Temperature: 50°C (1~4 cycle)
55°C (5th cycle)
3. Test dwell time: 6Hrs
4. Temperature slope: 2°C/min
5. Test cycle: 5 cycle
6. Test Environment Curve:



Temperature cycle test

Test O.S. / Software:

Windows 2000 / Run PassMark Burn In Test Pro 4.0

Thermal profile data:

Onyx-215

Point	Temp. Stage(°C)	Spec	55	50	25	0	-5
1. BT-R08LDNQ REV:05 - U401		100	90.2	85.2	60.2	35.2	30.2
2. BT-R08LDNQ REV:05 - U1002		100	82	77	52	27	22
3. BT-R08LDNQ REV:05 - U1000		100	101.4	96.4	71.4	46.4	41.4
4. BT-R08LDNQ REV:05 - AP1117 -U1004		125	88.9	83.9	58.9	33.9	28.9
5. T040 REV:A02 - L6		115	79	74	49	24	19
6. T040 REV:A02 - U8		115	78.2	73.2	48.2	23.2	18.2
7. T040 REV:A02 - U7		155	71.3	66.3	41.3	16.3	11.3
8. T040 REV:A02 - U10		115	69.1	64.1	39.1	14.1	9.1
9. T040 REV:A02 - U9		100	69.9	64.9	39.9	14.9	9.9
10. T040 REV:A02 - U4		105	73.8	68.8	43.8	18.8	13.8
11. T040 REV:A02 - U3		105	75.3	70.3	45.3	20.3	15.3
12. T040 REV:A02 - U5		100	72.8	67.8	42.8	17.8	12.8
13. T040 REV:A02 - U6		100	71.7	66.7	41.7	16.7	11.7
14. Inverter - Q2		150	102.5	97.5	72.5	47.5	42.5
15. Inverter - Q4		150	91.8	86.8	61.8	36.8	31.8
16. Inverter - Q6		150	85.9	80.9	55.9	30.9	25.9
17. Inverter - T2		200	84.7	79.7	54.7	29.7	24.7
18. Inverter - Q7		150	88.5	83.5	58.5	33.5	28.5
19. Inverter - Q8		150	88.5	83.5	58.5	33.5	28.5
20. Inverter - IC1		85	84.8	79.8	54.8	29.8	24.8
21. Inverter - SX14		125	86.3	81.3	56.3	31.3	26.3
22. Chamber Air Temperature		N/A	55.2	50.2	25.2	0.2	-4.8

Note: The description in red states which temperature is over the specification of the device.

Temperature cycle test

Sample Configuration & Quantity Under Test:

Quantity: 1 (Onyx-215)

Test Result:

No problem was found during the temperature cycle test.

Test Date: 01-10~12-2006

Test Product: Onyx-215

Test Site: AAEON QA Internal Lab.

Performed By: Ryan Cheng

Test Standard: Reference IEC 68-2-2 Testing procedures
Test Bb: Dry Heat Test (Non-operation)

Test Equipment:

Programmable Temperature & Humidity Chamber
K.SON. INS. TECH. CORP.

Model: THS-D4L+-100

Date of Calibration: 11/21/05

Serial Number: 2582

Testing Item:

1. Test Temperature: 60°C
2. Test Times: 48Hrs
3. Test Software: Windows 2000 / Run PassMark Burn In Test Pro 4.0
4. Test Environment Curve:



Sample Configuration & Quantity Under Test:

Quantity: 1 (Onyx-215)

Test Result:

No problem was found after the high temperature storage test.

Test Date: 01-06~09-2006

Test Product: Onyx-215

Test Site: AAEON QA Internal Lab.

Performed By: Ryan Cheng

Test Standard: Reference IEC 68-2-1
Testing procedures Test Ab: Cold Test (Non-operation)

Test Equipment:
Programmable Temperature & Humidity Chamber
K.SON. INS. TECH. CORP.
Model: THS-D4H+-100
Date of Calibration: 10/01/04
Serial Number: 2582

Testing Item:

1. Test Temperature: -20°C
2. Test Times: 48Hrs
3. Test Software: Windows 2000 / Run PassMark Burn In Test Pro 4.0
4. Test Environment Curve:



Sample Configuration & Quantity Under Test:

Quantity: 1 (Onyx-215)

Test Result:

No problem was found after the low temperature storage test.

Test Date: 01-03~05-2006

Test Product: Onyx-215

Test Site: AAEON QA Internal Lab.

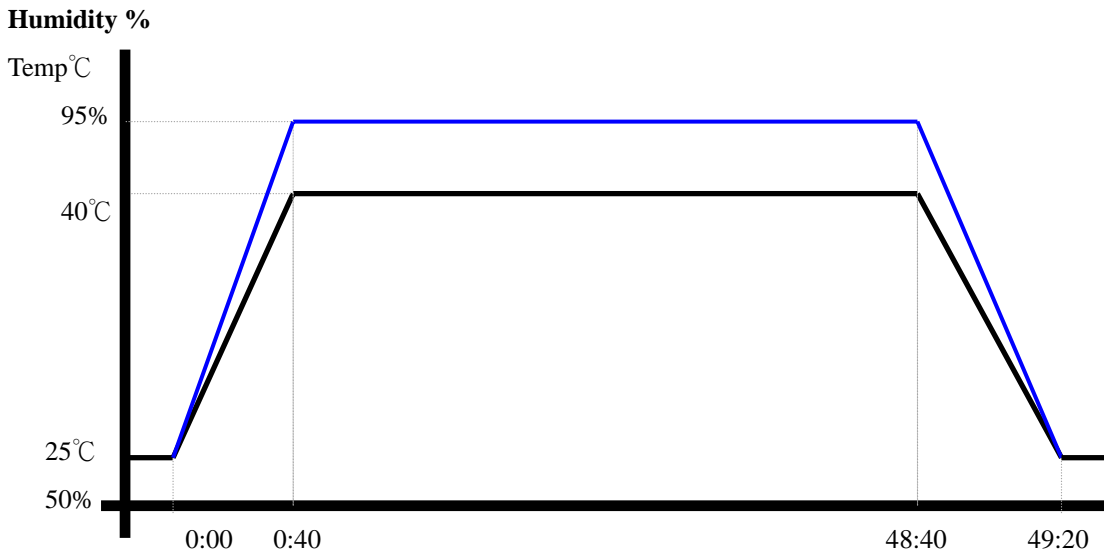
Performed By: Ryan Cheng

Test Standard: Reference IEC 68-2-3 Testing procedures
Test Ca: Damp heat, steady state (Non-operation)

Test Equipment:
Programmable Temperature & Humidity Chamber
K.SON. INS. TECH. CORP.
Model: THS-D4H+-100
Date of Calibration: 10/01/04
Serial Number: 2582

Testing Item:

1. Test Temperature: 40°C
2. Test Humidity: 95%RH
3. Test Times: 48Hrs
4. Test Software: Windows 2000 / Run PassMark Burn In Test Pro 4.0
5. Test Environment Curve:



Sample Configuration & Quantity Under Test:
Quantity: 1 (Onyx-215)

Test Result:
No problem was found after the humidity test.

Test Date: 01-02~03-2006

Test Product: Onyx-215

Test Site: AAEON QA Internal Lab.

Performed By: Ryan Cheng

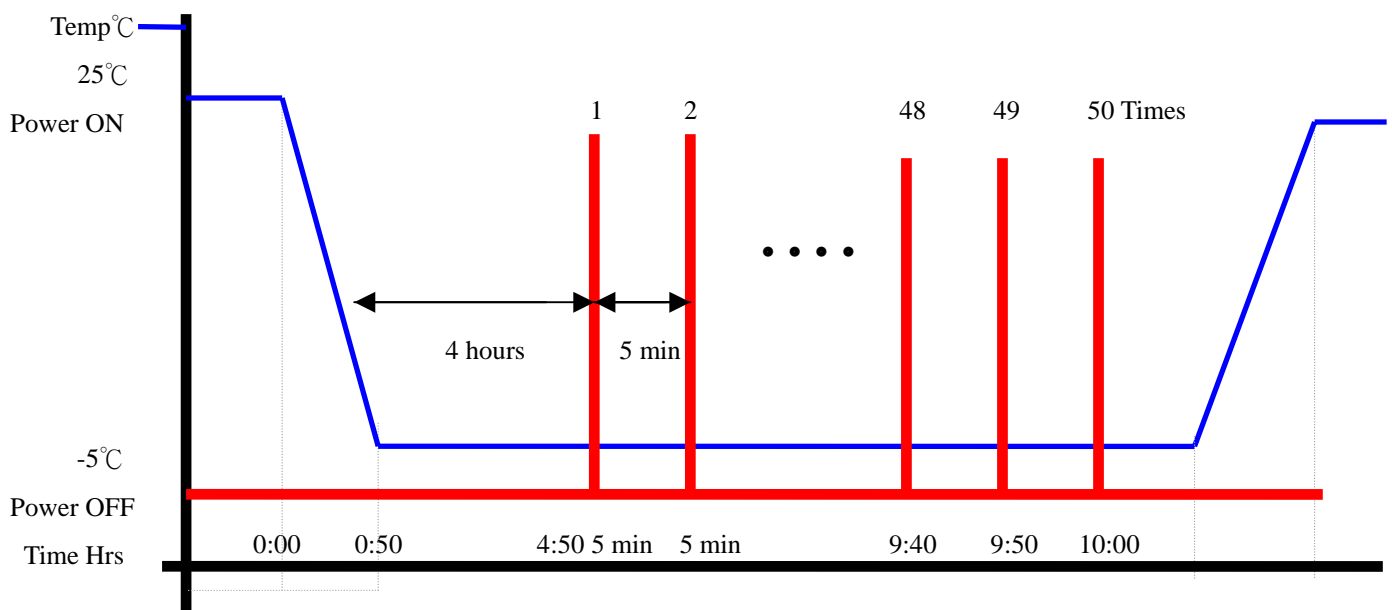
Test Standard: Reference IEC 68-2-1 Testing procedures
Test Ab: Cold Test

Test Equipment:

Programmable Temperature & Humidity Chamber
K.SON. INS. TECH. CORP.
Model: THS-D4H+-100
Date of Calibration: 10/01/04
Serial Number: 2582

Test Condition:

1. Test Temperature: -5°C
2. Test Times: 5 Hours or 50 times of ON/OFF
 - (1) Power off for 4 hours after 1'st power on. Then once complete boot, power off immediately.
 - (2) After 5 min later power on again and wait until booting is completed.
 - (3) Repeat (2) for around 4:50
 - (4) Power off then wait for 5 min before final power on operation.
3. Number of test: 50 times
4. Test Software: Windows 2000
5. Test Environment Curve:



Sample Configuration & Quantity Under Test:

Quantity: 1 (Onyx-215)

Test Result:

No problem was found during the cold start test.